DATA SHEET

μ**PD78F9116B, 78F9116B(A)**

MOS INTEGRATED CIRCUITS

8-BIT SINGLE-CHIP MICROCONTROLLERS

DESCRIPTION

The μ PD78F9116B is a μ PD789114A Subseries product of the 78K/0S Series.

The μ PD78F9116B replaces the internal ROM of the μ PD789111A,789112A and 789114A with flash memory, which enables the writing/erasing of a program while the device is mounted on the board.

A stricter quality assurance program (called special grade in NEC's grade classification) is applied to the μ PD78F9116B(A), compared to the μ PD78F9116B, which are classified as standard grade.

Because flash memory allows the program to be written and erased electrically with the device mounted on the board, this product is ideal for the evaluation stages of system development, small-scale production, and rapid development of new products.

Detailed function descriptions are provided in the following user's manuals. Be sure to read them before designing.

μPD789104A, 789114A, 789124A, 789134A Subseries User's Manual: U14643E 78K/0S Series User's Manual Instruction: U11047E

FEATURES

- Pin-compatible with mask ROM version (excluding VPP pin)
- Flash memory: 16 KB
- Internal high-speed RAM: 256 bytes
- On-chip multiplier: 8 bits × 8 bits = 16 bits
- Minimum instruction execution time can be changed from high-speed (0.2 μs) to low-speed (0.8 μs) (@ 10.0 MHz operation with system clock, V_{DD} = 4.5 to 5.5 V)
- I/O ports: 20
- Serial interface: 1 channel: Switchable between 3-wire serial I/O and UART modes
- 10-bit resolution A/D converter: 4 channels
- Timers: 3 channels
 - 16-bit timer: 1 channel
 - 8-bit timer/event counter: 1 channel
 - Watchdog timer: 1 channel
- Power supply voltage: VDD = 1.8 to 5.5 V

APPLICATIONS

Cleaners, washing machines, refrigerators and battery-charger

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version. Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

ORDERING INFORMATION

Part number	Package	Quality grade
μPD78F9116BMC-5A4	30-pin plastic SSOP (7.62 mm (300))	Standard
μPD78F9116BMC(A)-5A4	30-pin plastic SSOP (7.62 mm (300))	Special

Please refer to "Quality Grades on NEC Semiconductor Devices" (Document No. C11531E) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

78K/0S SERIES LINEUP

The products in the 78K/0S Series are listed below. The names enclosed in boxes are subseries names.

		/ Produ	ucts in mass
		/ produ	action development
		Y subseries supports SM	В.
	F	Small-scale package, general-purpose applic	
	44-pin 42-/44-pin 30-pin 28-pin 20-pin 20-pin	<u> </u>	μ PD789074 with subsystem clock added μ PD789014 with enhanced timer function and expanded ROM and RAM μ PD789074 with enhanced timer function and expanded ROM and RAM μ PD789026 with enhanced timer function On-chip UART and capable of low-voltage (1.8 V) operation RC oscillation version of μ PD789052 μ PD789860 without EEPROM TM , POC, and LVI
		Small-scale package, general-purpose applie	cations and A/D function
	44-pin 44-pin 30-pin 30-pin 30-pin 30-pin 30-pin	<u> </u>	μ PD789167 with 10-bit A/D μ PD789104A with enhanced timer μ PD789146 with 10-bit A/D μ PD789104A with EEPROM added μ PD789124A with 10-bit A/D RC oscillation version of μ PD789104A μ PD789104A with 10-bit A/D μ PD789026 with 8-bit A/D and multiplier added
	_	LCD drive	
78K/0S Series	144-pin 88-pin 80-pin 80-pin 80-pin 64-pin 64-pin 64-pin 64-pin 64-pin 64-pin 52-pin 52-pin 52-pin	/ µPD789835 / µPD789830 / µPD789483 / µPD789488 / µPD789478 / µPD789478 / µPD789467 / µPD789466 / µPD789466 / µPD789466 / µPD789306 / µPD789306 / µPD789306 / µPD789327 USB / µPD789803 / µPD789800	UART + 8-bit A/D + dot LCD (total display outputs: 96) UART + dot LCD (40 × 16) SIO + 10-bit A/D + internal voltage boosting method LCD (28 × 4) µPD789407A with 10-bit A/D SIO + 8-bit A/D + resistance division method LCD (28 × 4) µPD789446 with 10-bit A/D SIO + 8-bit A/D + internal voltage boosting method LCD (15 × 4) µPD789426 with 10-bit A/D SIO + 8-bit A/D + internal voltage boosting method LCD (15 × 4) µPD789426 with 10-bit A/D SIO + 8-bit A/D + internal voltage boosting method LCD (5 × 4) RC oscillation version of µPD789306 SIO + internal voltage boosting method LCD (23 × 4) 8-bit A/D + internal voltage boosting method LCD (23 × 4) SIO + resistance division method LCD (24 × 4) For PC keyboard. On-chip USB HUB function For PC keyboard. On-chip USB function
	— 44-pin	Inverter control	On-chip inverter controller and UART
	— 30-pin	On-chip bus controller	On-chip CAN controller
	30-pin 20-pin 20-pin	Keyless entry / µPD789862 / µPD789861 / µPD789860	μ PD789860 with enhanced timer function, added SIO, and expanded ROM and RAM RC oscillation version of μ PD789860 On-chip POC and key return circuit
	— 52-pin	VFD drive	On-chip VFD controller (total display outputs: 25)
	64-pin	Meter control	UART + resistance division method LCD (26 \times 4)

Remark VFD (Vacuum Fluorescent Display) is referred to as FIP[™] (Fluorescent Indicator Panel) in some documents, but the functions of the two are the same.

The major functional differences among the subseries are listed below.

Series for General-Purpose and LCD Drive

	Function	ROM		Ti	mer		8-Bit	10-Bit	Serial Interface	I/O	VDD	Remarks
Subseries	s Name	Capacity (Bytes)	8-Bit	16-Bit	Watch	WDT	A/D	A/D			MIN.Value	
Small-	μPD789046	16 K	1 ch	1 ch	1 ch	1 ch	-	-	1 ch (UART: 1ch)	34	1.8 V	-
scale	μPD789026	4 K to 16 K			-							
package, general-	µPD789088	16 K to 32 K	3 ch							24		
purpose	μPD789074	2 K to 8 K	1 ch									
applica- tions	μPD789014	2 K to 4 K	2 ch	-						22		
	μPD789062	4 K							_	14		RC-oscillation version
	μPD789052											_
Small-	μPD789177	16 K to 24 K	3 ch	1 ch	1 ch	1ch	-	8 ch	1 ch (UART: 1ch)	31	1.8 V	-
scale	μPD789167						8 ch	-				
package, general-	μPD789156	8 K to 16 K	1 ch		_		-	4 ch		20		On-chip
purpose	μPD789146						4 ch	-				EEPROM
applica- tions +	μPD789134A	2 K to 8 K					-	4 ch				RC-oscillation
A/D	μPD789124A						4 ch	-				version
converter	μPD789114A						-	4 ch				_
	μPD789104A						4 ch	-				
LCD	μPD789835	24 K to 60 K	6 ch	-	1 ch	1 ch	3 ch	-	1 ch (UART: 1ch)	37	$1.8 \text{ V}^{\text{Note}}$	Dot LCD
drive	μPD789830	24 K	1 ch	1 ch			-			30	2.7 V	supported
	μPD789488	32 K	3 ch					8 ch	2 ch (UART: 1ch)	45	1.8 V	-
	μPD789478	24 K to 32 K					8 ch	-				
	μPD789417A	12 K to 24 K					-	7 ch	1 ch (UART: 1ch)	43		
	μPD789407A						7 ch					
	μPD789456	12 K to 16 K	2 ch				-	6 ch		30		
	μPD789446						6 ch	-				
	μPD789436						-	6 ch		40		
	μPD789426						6 ch	-				
	μPD789316	8 K to 16 K					-		2 ch (UART: 1ch)	23		RC-oscillation version
	μPD789306											-
	μPD789467	4 K to 24 K		-			1 ch		_	18]	
	μPD789327						-		1 ch	21	1	

Note Flash memory version: 3.0 V

Series for ASSP

		ROM		Tii	mer		8-Bit	10-Bit	Serial Interface	I/O	VDD	Remarks
Subseries	s Name	Capacity (Bytes)	8-Bit	16-Bit	Watch	WDT	A/D	A/D			MIN.Value	
USB	µPD789803	8 K to 16 K	2 ch	-	-	1 ch	-	-	2 ch (USB: 1 ch)	41	3.6 V	-
	µPD789800	8 K								31	4.0 V	
Inverter control	μPD789842	8 K to 16 K	3 ch	Note 1	1 ch	1 ch	8 ch	_	1 ch (UART: 1 ch)	30	4.0 V	-
On-chip bus controller	μPD789850	16 K	1 ch	1 ch	_	1 ch	4 ch	-	2 ch (UART: 1 ch)	18	4.0 V	-
Keyless entry	μPD789861	4 K	2 ch	_	_	1 ch	_	_	_	14	1.8 V	RC-oscillation version, on-chip EEPROM
	μPD789860											On-chip EEPROM
	µPD789862	16 K	1 ch	2 ch					1 ch (UART: 1 ch)	22		
VFD drive	μPD789871	4 K to 8 K	3 ch	—	1 ch	1 ch	_	I	1 ch		2.7 V	_
Meter control	μPD789881	16 K	2 ch	1 ch	-	1 ch	-	-	1 ch (UART: 1 ch)	28	2.7 V ^{Note 2}	_

Notes 1. 10-bit timer: 1 channel

2. Flash memory version: 3.0 V

OVERVIEW OF FUNCTIONS

lt	em	function	function					
Internal memory	Flash memory	16 KB						
	High-speed RAM	256 bytes						
Minimum instruction	execution time	0.2/0.8 μ s (@ 10.0 MHz operation with system	n clock, V _{DD} = 4.5 to 5.5 V)					
General-purpose rec	jisters	8 bits \times 8 registers						
Instruction set		16-bit operationsBit manipulations (set, reset, and test)						
Multiplier		8 bits \times 8 bits = 16 bits						
I/O ports		_Total:	20					
		 CMOS input: 4 CMOS I/O: 12 N-ch open-drain (12 V withstand voltage): 4 						
A/D converters		10-bit resolution × 4 channels						
Serial interface		Switchable between 3-wire serial I/O and UAR	Switchable between 3-wire serial I/O and UART modes					
Timer		 16-bit timer: 1 channel 8-bit timer/event counter: 1 channel Watchdog timer: 1 channel 						
Timer output		1 output (16-bit/8-bit timer alternate function)						
Vectored interrupt	Maskable	Internal: 6, External: 3						
sources	Non-maskable	Internal: 1						
Power supply voltag	e	V _{DD} = 1.8 to 5.5 V						
Operating ambient te	emperature	$T_{A} = -40 \text{ to } +85^{\circ}\text{C}$						
Package		30-pin plastic SSOP (7.62 mm (300))						

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1. PIN CONFIGURATION (TOP VIEW)

 30-pin plastic SSOP (7.62 mm (300)) μPD78F9116BMC-5A4 μPD78F9116BMC(A)-5A4

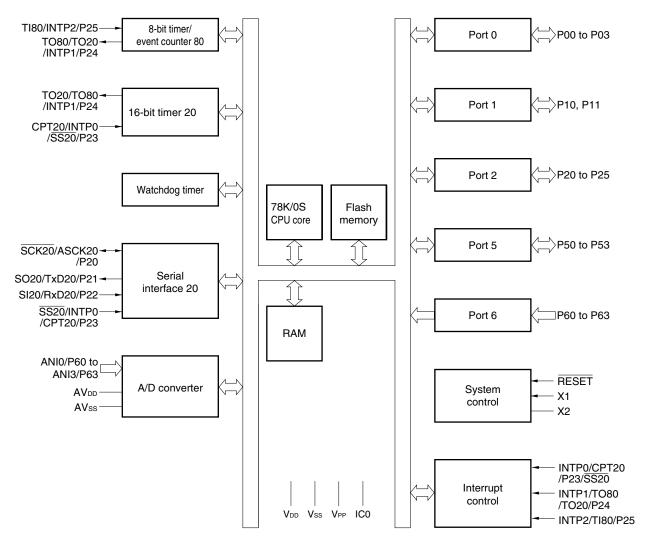
> P23/INTP0/CPT20/SS20 0 30 ► 0 P22/SI20/RxD20 1 \bigcirc P24/INTP1/TO80/TO20 O-2 29 - P21/SO20/TxD20 P25/INTP2/TI80 --3 ► P20/SCK20/ASCK20 28 AVDD O-4 27 P60/ANI0 -5 -> P10 26 P61/ANI1 O-6 25 P62/ANI2 -7 24 -O Vss P63/ANI3 -8 23 --- X1 AVss O-9 22 -0 X2 IC0 O-10 21 --- IC0 P50 O-11 20 -0 RESET P51 O-12 19 P52 O-13 18 P53 O-14 17 ►0 P02 P00 O-15 16 ► • P01

Cautions 1. Connect the IC0 (Internally Connected) pin directly to Vss.

- 2. Connect the VPP pin directly to Vss in normal operation mode.
- 3. Connect the AVDD pin to VDD.
- 4. Connect the AVss pin to Vss.

ANI0 to ANI3:	Analog input	RESET:	Reset
ASCK20:	Asynchronous serial input	RxD20:	Receive data
AVDD:	Analog power supply	SCK20:	Serial clock input/output
AVss:	Analog ground	SI20:	Serial data input
CPT20:	Capture trigger input	SO20:	Serial data output
IC0:	Internally connected	SS20:	Chip select input
INTP0 to INTP2:	Interrupt from peripherals	TI80:	Timer input
P00 to P03:	Port0	TO20, TO80:	Timer output
P10, P11:	Port1	TxD20:	Transmit data
P20 to P25:	Port2	VDD:	Power supply
P50 to P53:	Port5	VPP:	Programming power supply
P60 to P63:	Port6	Vss:	Ground
		X1, X2:	Crystal 1, 2

2. BLOCK DIAGRAM



3. DIFFERENCES BETWEEN μ PD78F9116B, 78F9116B(A), AND MASK ROM VERSIONS

The μ PD78F9116B and 78F9116B(A) are products in which flash memory is substituted for the internal ROM of the mask ROM version. The differences between the μ PD78F9116B, 78F9116B(A), and the mask ROM versions are shown in Table 3-1.

Item		Flash Memory Version	Mask ROM Version				
		μPD78F9116B μPD78F9116B(A)	μPD789111A μPD789111A(A)	μPD789112A μPD789112A(A)	μPD789114A μPD789114A(A)		
Internal	ROM	16 KB (Flash memory)	2 KB	2 KB 4 KB 8 KB			
memory	High-speed RAM	256 bytes					
Pull-up resis	tor	12 (software control only)	16 (software control	: 12, mask option spe	cification: 4)		
VPP pin		Provided Not provided					
Electric char	acteristics	See the relevant data sheet					

Table 3-1. Differences Between µPD78F9116B, 78F9116B(A), and Mask ROM Versions

Caution There are differences in noise immunity and noise radiation between the flash memory and mask ROM versions. When pre-producing an application set with the flash memory version and then mass-producing it with the mask ROM version, be sure to conduct sufficient evaluations for the commercial samples (not engineering samples) of the mask ROM version.

4. PIN FUNCTIONS

4.1 Port Pins

Pin Name	I/O	Function	After Reset	Alternate Function
P00 to P03	I/O	Port 0 4-bit I/O port Input/output can be specified in 1-bit units When used as an input port, connection of an on-chip pull-up resistor can be specified by software.	Input	_
P10, P11	I/O	Port 1 2-bit I/O port Input/output can be specified in 1-bit units When used as an input port, an connection of on-chip pull-up resistor can be specified by software.	Input	_
P20	I/O	Port 2	Input	SCK20/ASCK20
P21		6-bit I/O port		SO20/TxD20
P22		Input/output can be specified in 1-bit units		SI20/RxD20
P23		When used as an input port, an connection of on-chip pull-up resistor can be specified by software.		INTP0/CPT20 /SS20
P24				INTP1/TO80/TO20
P25				INTP2/TI80
P50 to P53	I/O	Port 5 4-bit N-ch open-drain input/output port Input/output can be specified in 1-bit units.	Input	_
P60 to P63	Input	Port 6 4-bit input-only port	Input	ANI0 to ANI3

4.2 Non-Port Pins

Pin Name	I/O	Function	After Reset	Alternate Function
INTP0	Input	External interrupt request input for which the valid edge	Input	P23/CPT20/SS20
INTP1		(rising edge, falling edge, or both rising and falling edges) can		P24/TO80/TO20
INTP2		be specified		P25/TI80
SI20	Input	Serial interface serial data input	Input	P22/RxD20
SO20	Output	Serial interface serial data output	Input	P21/TxD20
SCK20	I/O	Serial interface serial clock input/output	Input	P20/ASCK20
ASCK20	Input	Serial clock input for asynchronous serial interface	Input	P20/SCK20
SS20	Input	Chip select input for serial interface	Input	P23/CPT20/INTP0
RxD20	Input	Serial data input for asynchronous serial interface	Input	P22/SI20
TxD20	Output	Serial data output for asynchronous serial interface	Input	P21/SO20
TI80	Input	External count clock input to 8-bit timer/event counter 80	Input	P25/INTP2
TO80	Output	8-bit timer/event counter 80 output	Input	P24/INTP1/TO20
TO20	Output	16-bit timer 20 output	Input	P24/INTP1/TO80
CPT20	Input	Capture edge input	Input	P23/INTP0/SS20
ANI0 to ANI3	Input	A/D converter analog input	Input	P60 to P63
AVDD	-	A/D converter analog power supply	-	-
AVss	-	A/D converter ground potential	-	-
X1	Input	Connecting crystal resonator for main system clock oscillation	-	-
X2	-		-	-
RESET	Input	System reset input	Input	-
Vdd	-	Positive power supply	_	-
Vss	-	Ground potential	-	-
Vpp	-	Sets flash memory programming mode. Applies high voltage when a program is written or verified.	-	-
IC0	-	Internally connected. Connect directly to Vss.	-	_

4.3 Pin I/O Circuits and Recommended Connection of Unused Pins

The input/output circuit type of each pin and recommended connection of unused pins are shown in Table 4-1. For the input/output circuit configuration of each type, refer to Figure 4-1.

Pin Name	Input/Output Circuit Type	I/O	Recommended Connection of Unused Pins
P00 to P03	5-A	I/O	Input: Independently connect to VDD or VSS via a resistor.
P10, P11			Output: Leave open
P20/SCK20/ASCK20	8-A		
P21/SO20/TxD20			
P22/SI20/RxD20			
P23/INTP0/CPT20/SS20			Input: Independently connect to Vss via a resistor.
P24/INTP1/TO80/TO20			Output: Leave open
P25/INTP2/TI80			
P50 to P53	13-V		Input: Independently connect to VDD via a resistor. Output: Leave open
P60/ANI0 to P63/ANI3	9-C	Input	Connect directly to VDD or Vss.
AVDD	-	_	Connect directly to VDD.
AVss			Connect directly to Vss.
RESET	2	Input	_
IC0	_	-	Connect directly to Vss.
Vpp			Connect a 10 k Ω pull-down resistor or connect directly to Vss.

Table 4-1. Types of Pin Input/Output Circuits

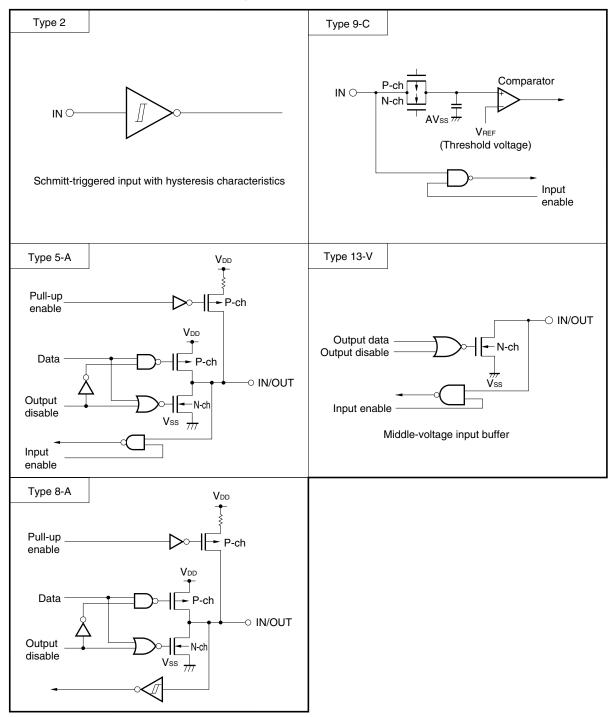


Figure 4-1. Pin I/O Circuits

5. MEMORY SPACE

Figure 5-1 shows the memory map of the μ PD78F9116B and 78F9116B(A).

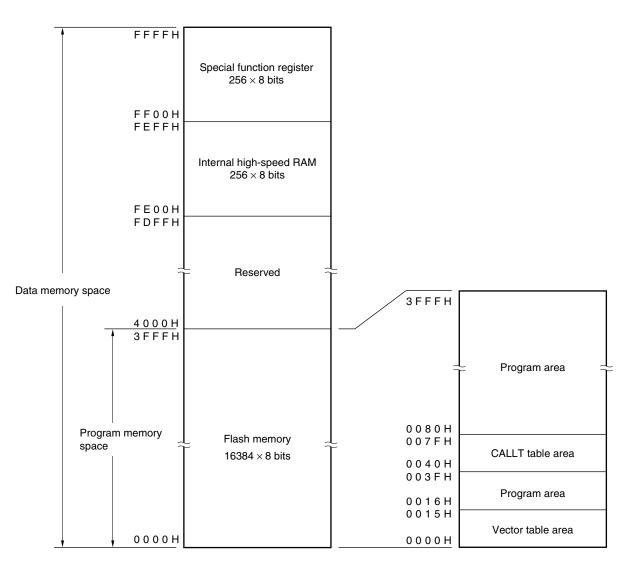


Figure 5-1. Memory Map

6. FLASH MEMORY CHARACTERISTICS

Flash memory programming is performed by connecting a dedicated flash programmer (Flashpro III (part no. FL-PR3, PG-FP3)/Flashpro IV^{Note} (part no. FL-PR4, PG-FP4)) to the target system with the flash memory mounted on the target system (on-board). A flash memory writing adapter (program adapter), which is a target board used exclusively for programming, is also provided.

Note Under development

Remark FL-PR3, FL-PR4, and the program adapter are the products made by Naito Densei Machida Mfg. Co., Ltd. (TEL +81-45-475-4191).

Programming using flash memory has the following advantages.

- Software can be modified after the microcontroller is solder-mounted on the target system.
- Distinguishing software facilities low-quantity, varied model production
- · Easy data adjustment when starting mass production

6.1 Programming Environment

The following shows the environment required for μPD78F9116B and 78F9116B(A) flash memory programming. When Flashpro III (part no. FL-PR3, PG-FP3) or Flashpro IV (Part no. FL-PR4, PG-FP4) is used as a dedicated flash programmer, a host machine is required to control the dedicated flash programmer. Communication between the host machine and flash programmer is performed via RS-232C/USB (Rev. 1.1).

For details, refer the manuals for Flashpro III/Flashpro IV.

Remark USB is supported by Flashpro IV only.

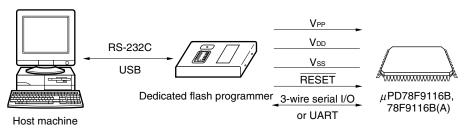


Figure 6-1. Environment for Writing Program to Flash Memory

6.2 Communication Mode

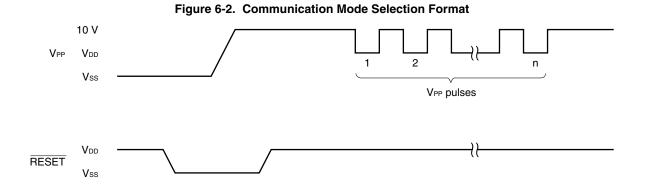
Use the communication mode shown in Table 6-1 to perform communication between the dedicated flash programmer and the μ PD78F9116B or 78F9116B(A).

Communication		-	Pins used	Number of VPP			
Mode	COMM PORT	SIO clock	CPU clock	Flash clock	Multiple rate		pulses
3-wire serial I/O (SIO3)	SIO ch-0 (3-wire, sync.) SIO ch-1 (3-wire, sync.)	100 Hz to 1.25 MHz ^{Note 2}	Optional	1 to 10 MHz ^{Note 2}	1.0	SCK20/ASCK20/P20 SO20/TxD20/P21 SI20/RxD20/P22 P00 P01 P02	0
UART (UART0)	UART ch-0	4800 to 76800 bps ^{Note 2, 3}	Optional	1 to 10 MHz ^{Note 2}		TxD20/SO20/P21 RxD20/SI20/P22	8

 Table 6-1.
 Communication Mode List

Notes 1. Selection items for TYPE settings on the dedicated flash programmer (Flashpro III (part no. FL-PR3, PG-FP3)/Flashpro IV (Part no. FL-PR4, PG-FP4)).

- 2. The possible setting range differs depending on the voltage. For details, refer to 8. ELECTRICAL SPECIFICATIONS.
- Caution Be sure to select a communication mode depending on the number of VPP pulses shown in Table 6-1.



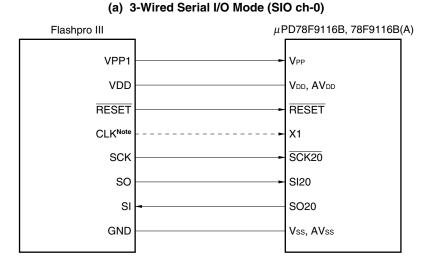
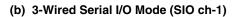
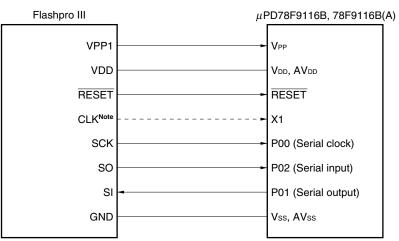
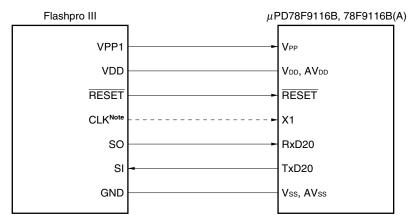


Figure 6-3. Example of Connection with Dedicated Flash Programmer





- **Note** Connect this pin when the system clock is supplied by Flashpro III. When a resonator has already been connected to the X1 pin, the CLK pin does not need to be connected.
- Caution The VDD pin, if already connected to the power supply, must be connected to the VDD pin of the dedicated flash programmer. Before using the power supply connected to the VDD pin, supply voltage before starting programming.



(c) UART Mode

- **Note** Connect this pin when the system clock is supplied by Flashpro III. When a resonator has already been connected to the X1 pin, the CLK pin does not need to be connected.
- Caution The V_{DD} pin, if already connected to the power supply, must be connected to the VDD pin of the dedicated flash programmer. Before using the power supply connected to the V_{DD} pin, supply voltage before starting programming.

If Flashpro III (part no. FL-PR3, PG-FP3)/Flashpro IV is used as a dedicated flash programmer, the following signals are generated for the μ PD78F9116B and 78F9116B(A). For details, refer to the manual of Flashpro III/Flashpro IV.

Signal Name	I/O	Pin Function	Pin Name	3-Wire Serial I/O	UART
VPP1	Output	Write voltage	Vpp	۵	۵
VPP2	-	-		×	×
VDD	I/O	VDD voltage generation/voltage monitoring	Vdd/AVdd	© ^{Note}	∕ ◎ ^{Note}
GND	_	Ground	Vss/AVss	۵	۵
CLK	Output	Clock output	X1	0	0
RESET	Output	Reset signal	RESET	۵	۵
SI	Input	Reception signal	SO20/P01/TxD20	۵	۵
SO	Output	Transmit signal	SI20/P02/RxD20	۵	٥
SCK	Output	Transfer clock	SCK20/P00	۵	×
HS	-	_	-	×	×

Table 6-2. Pin Connection List

Note VDD voltage must be supplied before programming is started.

Remark ©: Pin must be connected.

- o: If the signal is supplied on the target board, pin need not be connected.
- $\times\!\!:$ Pin need not be connected.

6.3 On-Board Pin Processing

When performing programming on the target system, provide a connector on the target system to connect the dedicated flash programmer.

An on-board function that allows switching between normal operation mode and flash memory programming mode may be required in some cases.

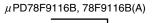
<VPP pin>

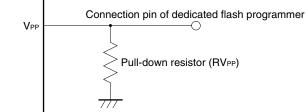
In normal operation mode, input 0 V to the VPP pin. In flash memory programming mode, a write voltage of 10.0 V (TYP.) is supplied to the VPP pin, so perform the following.

- (1) Connect a pull-down resistor ($RV_{PP} = 10 \text{ k}\Omega$) to the VPP pin.
- (2) Use the jumper on the board to switch the V_{PP} pin input to either the writer or directly to GND.

A VPP pin connection example is shown below.







<Serial interface pin>

The following shows the pins used by the serial interface.

Serial Interface	Pins Used
3-wire serial I/O (SIO3)	SCK20, SO20, SI20
	P00, P01, P02
UART	TxD20, RxD20

When connecting the dedicated flash programmer a serial interface pin that is connected to another device onboard, signal conflict or abnormal operation of the other devices may occur. Care must therefore be taken with such connections.

(1) Signal conflict

If the dedicated flash programmer (output) is connected to a serial interface pin (input) that is connected to another device (output), a signal conflict occurs. To prevent this, isolate the connection with the other device or set the other device to the output high impedance status.

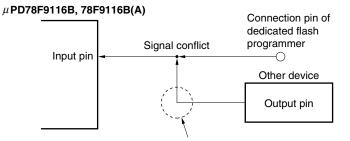
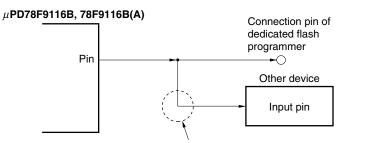


Figure 6-5. Signal Conflict (Input Pin of Serial Interface)

In the flash memory programming mode, the signal output by another device and the signal sent by the dedicated flash programmer conflict, therefore, isolate the signal of the other device.

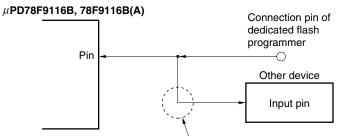
(2) Abnormal operation of other device

If the dedicated flash programmer (output or input) is connected to a serial interface pin (input or output) that is connected to another device (input), a signal is output to the device, and this may cause an abnormal operation. To prevent this abnormal operation, isolate the connection with the other device or set so that the input signals to the other device are ignored.





If the signal output by the $\mu PD78F9116B$ or 78F9116B(A) affects another device in the flash memory programming mode, isolate the signals of the other device.



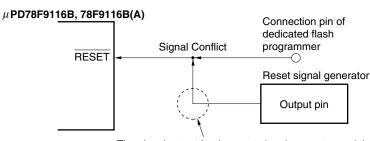
If the signal output by the dedicated flash programmer affects another device in the flash memory programming mode, isolate the signals of the other device.

<RESET pin>

If the reset signal of the dedicated flash programmer is connected to the RESET pin connected to the reset signal generator on-board, a signal conflict occurs. To prevent this, isolate the connection with the reset signal generator.

If the reset signal is input from the user system in the flash memory programming mode, a normal programming operation cannot be performed. Therefore, do not input reset signals from other than the dedicated flash programmer.

Figure 6-7. Signal Conflict (RESET Pin)



The signal output by the reset signal generator and the signal output from the dedicated flash programmer conflict in the flash memory programming mode, so isolate the signal of the reset signal generator.

<Port pins>

When the μ PD78F9116B or 78F9116B(A) enters the flash memory programming mode, all the pins other than those that communicate in flash memory programming are in the same status as immediately after reset. If the external device does not recognize initial statuses such as the output high impedance status, therefore, connect the external device to V_{DD} or Vss.

<Oscillation pins>

When using the on-board clock, connect X1 and X2 as required in the normal operation mode. When using the clock output of the flash programmer, connect it directly to X1, disconnecting the main resonator on-board, and leave the X2 pin open.

<Power supply>

When using the power supply output of the flash programmer, connect the V_{DD} and V_{SS} pins to VDD and GND of the flash programmer, respectively.

When using the on-board power supply, connect it as required in the normal operation mode. Because the flash programmer monitors the voltage, however, VDD of the flash programmer must be connected.

For the other power pins (AVDD and Ass), supply the same power supply as in the normal operation mode.

6.4 Connection When Using Flash Memory Writing Adapter

The following shows an example of the recommended connection when using the flash memory writing adapter.

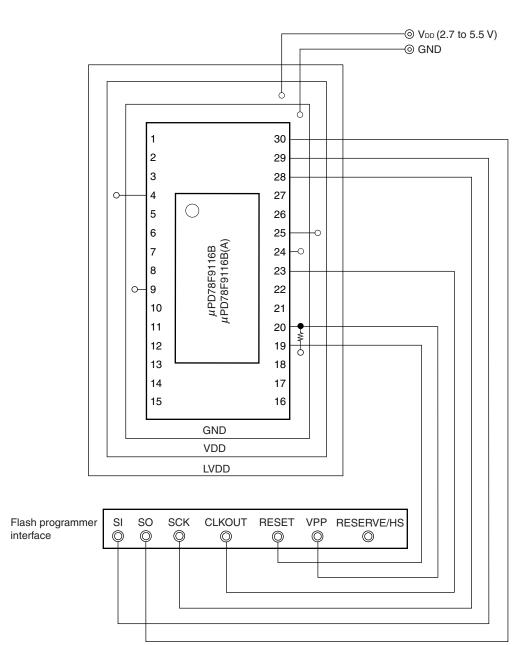


Figure 6-8. Example of Flash Memory Writing Adapter Connection When Using 3-Wire Serial I/O Mode (SIO-ch0)

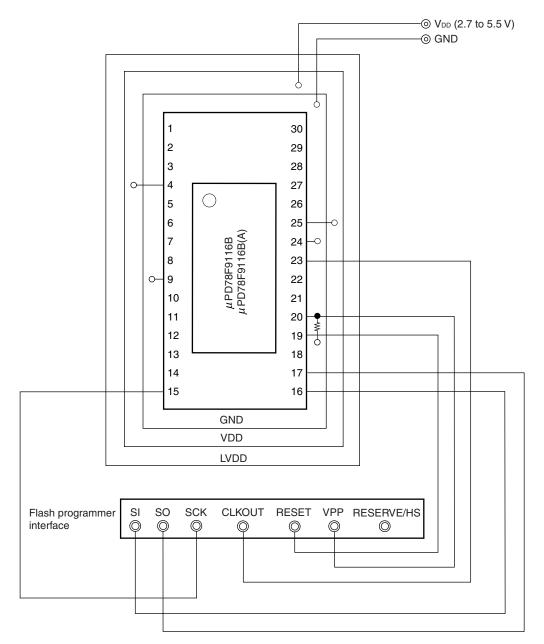


Figure 6-9. Example of Flash Memory Writing Adapter Connection When Using 3-Wire Serial I/O Mode (SIO-ch1)

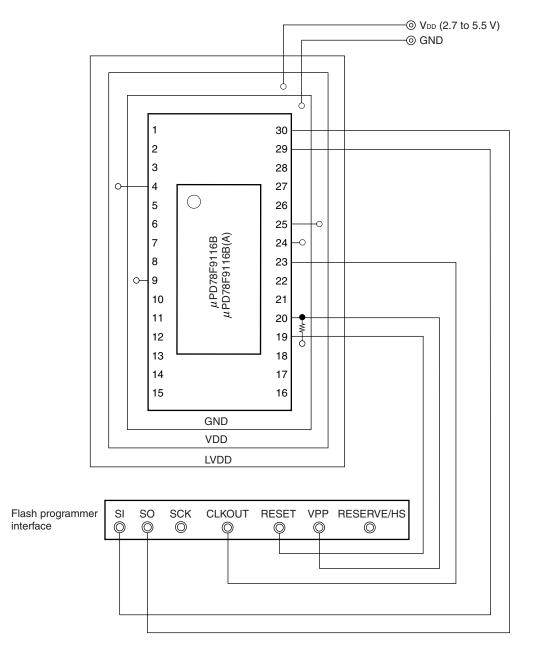


Figure 6-10. Example of Flash Memory Writing Adapter Connection When Using UART Mode

7. INSTRUCTION SET OVERVIEW

This section shows a list of the instruction set for the μ PD78F9116B and 78F9116B(A).

7.1 Conventions

7.1.1 Operand identifiers and description methods

Operands are described in the "Operand" column of each instruction in accordance with the description method of the instruction operand identifier (refer to the assembler specifications for detail). When there are two or more description methods, select one of them. Alphabetic letters in capitals and the symbols, #, !, \$, and [], are keywords and must be described as they are. Each symbol has the following meaning.

- #: Immediate data specification
 - \$: Relative address specification
- !: Absolute address specification
- []: Indirect address specification

In the case of immediate data, describe an appropriate numeric value or a label. When using a label, be sure to describe the #,!, \$, or [] symbols.

For operand register identifiers, r and rp, either function names (X, A, C, etc.) or absolute names (names in parentheses in the table below, R0, R1, R2, etc.) can be used for description.

Identifier	Description Method
r	X (R0), A (R1), C (R2), B (R3), E (R4), D (R5), L (R6), H (R7),
rp	AX (RP0), BC (RP1), DE (RP2), HL (RP3)
sfr	Special function register symbol
saddr	FE20H to FF1FH immediate data or label
saddrp	FE20H to FF1FH immediate data or label (even address only)
addr16 addr5	0000H to FFFFH immediate data or label (Only even addresses for 16-bit data transfer instructions) 0040H to 007FH immediate data or label (even address only)
word	16-bit immediate data or label
byte	8-bit immediate data or label
bit	3-bit immediate data or label

Table 7-1. Operand Identifiers and Description Methods

A:	A register; 8-bit accumulator
X:	X register
B:	B register
C:	C register
D:	D register
E:	E register
H:	H register
L:	L register
AX:	AX register pair; 16-bit accumulator
BC:	BC register pair
DE:	DE register pair
HL:	HL register pair
PC:	Program counter
SP:	Stack pointer
PSW:	Program status word
CY:	Carry flag
AC:	Auxiliary carry flag
Z:	Zero flag
IE:	Interrupt request enable flag
NMIS:	Non-maskable interrupt servicing flag
():	Memory contents indicated by address or register contents in parentheses
Xн, Xl:	Higher 8 bits and lower 8 bits of 16-bit register
∧:	Logical product (AND)
∨:	Logical sum (OR)
∀:	Exclusive OR
:	Inverted data
addr16:	16-bit immediate data or label
jdisp8:	Signed 8-bit data (displacement value)

7.1.3 Description of the flag operation field

7.1.2 Descriptions of the operation field

(Blank):	Not affected
0:	Cleared to 0

- 1: Set to 1
- \times : Set/cleared according to the result
- R: Previously saved value is restored

7.2 Operations

Mnemonic	Operand	Byte	Clock	Operation	Flag
					Z AC CY
MOV	r, #byte	3	6	$r \leftarrow byte$	
	saddr , #byte	3	6	$(addr) \leftarrow byte$	
	sfr, #byte	3	6	$sfr \leftarrow byte$	
·	A, r Note 1	2	4	$A \leftarrow r$	
	r, A Note 1	2	4	$r \leftarrow A$	
	A, saddr	2	4	$A \leftarrow (saddr)$	
	saddr, A	2	4	$(saddr) \gets A$	
	A, sfr	2	4	$A \leftarrow sfr$	
	sfr, A	2	4	$sfr \leftarrow A$	
	A, !addr16	3	8	$A \leftarrow (addr16)$	
	!addr16, A	3	8	$(addr16) \leftarrow A$	
	PSW, #byte	3	6	$PSW \leftarrow byte$	× × ×
	A, PSW	2	4	$A \leftarrow PSW$	
	PSW, A	2	4	$PSW \gets A$	× × ×
	A, [DE]	1	6	$A \leftarrow (DE)$	
	[DE], A	1	6	$(DE) \gets A$	
	A, [HL]	1	6	$A \leftarrow (HL)$	
	[HL], A	1	6	$(HL) \gets A$	
	A, [HL + byte]	2	6	$A \leftarrow (HL + byte)$	
	[HL + byte], A	2	6	$(HL + byte) \leftarrow A$	
ХСН	Α, Χ	1	4	$A \leftrightarrow X$	
	A, r Note 2	2	6	$A \leftrightarrow r$	
	A, saddr	2	6	$A \leftrightarrow (saddr)$	
	A, sfr	2	6	$A \leftrightarrow sfr$	
	A, [DE]	1	8	$A \leftrightarrow (DE)$	
	A, [HL]	1	8	$A \leftrightarrow (HL)$	
	A, [HL + byte]	2	8	$A \leftrightarrow (HL + byte)$	
MOVW	rp, #word	3	6	$rp \leftarrow word$	
	AX, saddrp	2	6	$AX \leftarrow (saddrp)$	
	saddrp, AX	2	8	$(saddrp) \leftarrow AX$	
	AX, rp Note 3	1	4	AX ← rp	
	rp, AX Note 3	1	4	$rp \leftarrow AX$	
XCHW	AX, rp Note 3	1	8	AX ↔rp	

Notes 1. Except r = A

2. Except r = A or X

3. Only when rp = BC, DE, HL

Remark One instruction clock cycle is one cycle of the CPU clock (fcPu), selected by the processor clock control register (PCC).

Mnemonic	Operand	Byte	Clock	Operation	Flag	g
					Z AC	C
ADD	A, #byte	2	4	A, CY \leftarrow A + byte	× ×	×
	saddr, #byte	3	6	(saddr), CY \leftarrow (saddr) + byte	× ×	×
	A, r	2	4	A, CY \leftarrow A + r	× ×	×
	A, saddr	2	4	A, CY \leftarrow A + (saddr)	× ×	>
	A, !addr16	3	8	A, CY \leftarrow A + (addr16)	× ×	>
	A, [HL]	1	6	A, CY \leftarrow A + (HL)	× ×	>
	A, [HL + byte]	2	6	A, CY \leftarrow A + (HL + byte)	x x	>
ADDC	A, #byte	2	4	A, CY \leftarrow A + byte + CY	× ×	>
	saddr, #byte	3	6	(saddr), CY \leftarrow (saddr) + byte + CY	x x	>
	A, r	2	4	$A, CY \leftarrow A + r + CY$	× ×	>
	A, saddr	2	4	A, CY \leftarrow A + (saddr) + CY	× ×	>
	A, !addr16	3	8	A, CY \leftarrow A + (addr16) + CY	× ×	>
	A, [HL]	1	6	$A, CY \leftarrow A + (HL) + CY$	× ×	;
	A, [HL + byte]	2	6	A, CY \leftarrow A + (HL + byte) + CY	× ×	;
SUB	A, #byte	2	4	A, CY \leftarrow A – byte	× ×	
	saddr, #byte	3	6	(saddr), CY \leftarrow (saddr) – byte	× ×	
	A, r	2	4	A, CY \leftarrow A – r	× ×	;
	A, saddr	2	4	A, CY \leftarrow A – (saddr)	× ×	;
	A, !addr16	3	8	A, CY \leftarrow A – (addr16)	× ×	;
	A, [HL]	1	6	A, CY \leftarrow A – (HL)	× ×	
	A, [HL + byte]	2	6	A, CY \leftarrow A – (HL + byte)	× ×	
SUBC	A, #byte	2	4	A, CY \leftarrow A – byte – CY	× ×	2
	saddr, #byte	3	6	(saddr), $CY \leftarrow (saddr) - byte - CY$	× ×	:
	A, r	2	4	$A,CY\leftarrowA-r-CY$	× ×	;
	A, saddr	2	4	A, $CY \leftarrow A - (saddr) - CY$	× ×	:
	A, !addr16	3	8	A, CY \leftarrow A – (addr16) – CY	× ×	2
	A, [HL]	1	6	$A, CY \leftarrow A - (HL) - CY$	× ×	:
	A, [HL + byte]	2	6	A, CY \leftarrow A – (HL + byte) – CY	× ×	;
AND	A, #byte	2	4	$A \leftarrow A \land byte$	×	
	saddr, #byte	3	6	$(saddr) \leftarrow (saddr) \land byte$	×	
	A, r	2	4	$A \leftarrow A \wedge r$	×	
	A, saddr	2	4	$A \leftarrow A \land (saddr)$	×	
	A, !addr16	3	8	$A \leftarrow A \land (addr16)$	×	
	A, [HL]	1	6	$A \leftarrow A \land (HL)$	×	
	A, [HL + byte]	2	6	$A \leftarrow A \land (HL + byte)$	×	

Remark One instruction clock cycle is one cycle of the CPU clock (fcPU), selected by the processor clock control register (PCC).

Mnemonic	Operand	Byte	Clock	Operation	Flag
					Z AC CY
OR	A, #byte	2	4	$A \leftarrow A \lor byte$	×
	saddr, #byte	3	6	$(saddr) \leftarrow (saddr) \lor byte$	×
	A, r	2	4	$A \leftarrow A \lor r$	×
	A, saddr	2	4	$A \leftarrow A \lor (saddr)$	×
	A, !addr16	3	8	$A \leftarrow A \lor (addr16)$	×
	A, [HL]	1	6	$A \leftarrow A \lor (HL)$	×
	A, [HL + byte]	2	6	$A \leftarrow A \lor (HL + byte)$	×
XOR	A, #byte	2	4	$A \leftarrow A \bigtriangledown$ byte	×
	saddr, #byte	3	6	$(saddr) \leftarrow (saddr) \lor byte$	×
	A, r	2	4	$A \leftarrow A \bigtriangledown r$	×
	A, saddr	2	4	$A \leftarrow A \forall$ (saddr)	×
	A, !addr16	3	8	$A \leftarrow A \lor (addr16)$	×
	A, [HL]	1	6	$A \leftarrow A \nleftrightarrow (HL)$	×
	A, [HL + byte]	2	6	$A \leftarrow A \bigtriangledown (HL + byte)$	×
CMP	A, #byte	2	4	A – byte	× × ×
	saddr, #byte	3	6	(saddr) – byte	× × ×
	A, r	2	4	A – r	× × ×
	A, saddr	2	4	A – (saddr)	× × ×
	A, !addr16	3	8	A – (addr16)	× × ×
	A, [HL]	1	6	A – (HL)	× × ×
	A, [HL + byte]	2	6	A – (HL + byte)	× × ×
ADDW	AX, #word	3	6	AX, CY \leftarrow AX + word	× × ×
SUBW	AX, #word	3	6	AX, CY \leftarrow AX – word	× × ×
CMPW	AX, #word	3	6	AX – word	× × ×
INC	r	2	4	r ← r + 1	x x
	saddr	2	4	$(saddr) \leftarrow (saddr) + 1$	× ×
DEC	r	2	4	r ← r − 1	x x
	saddr	2	4	$(saddr) \leftarrow (saddr) - 1$	x x
INCW	rp	1	4	$rp \leftarrow rp + 1$	
DECW	rp	1	4	$rp \leftarrow rp - 1$	
ROR	A, 1	1	2	$(CY,A_7 \leftarrow A_0,A_{m-1} \leftarrow A_m) \times 1$	×
ROL	A, 1	1	2	$(CY, A_0 \leftarrow A_7, A_{m+1} \leftarrow A_m) \times 1$	×
RORC	A, 1	1	2	$(CY \leftarrow A_0, A_7 \leftarrow CY, A_{m-1} \leftarrow A_m) \times 1$	×
ROLC	A, 1	1	2	$(CY \leftarrow A_7, A_0 \leftarrow CY, A_{m+1} \leftarrow A_m) \times 1$	×

Remark One instruction clock cycle is one cycle of the CPU clock (fcPU), selected by the processor clock control register (PCC).

Mnemonic	Operand	Byte	Clock	Operation	Flag		
					Z	AC	CY
SET1	saddr. bit	3	6	(saddr. bit) ← 1			
	sfr. bit	3	6	sfr. bit \leftarrow 1			
	A. bit	2	4	A. bit $\leftarrow 1$			
	PSW. bit	3	6	PSW. bit \leftarrow 1	×	×	×
	[HL]. bit	2	10	(HL) . bit \leftarrow 1			
CLR1	saddr. bit	3	6	$(saddr. bit) \leftarrow 0$			
	sfr. bit	3	6	sfr. bit $\leftarrow 0$			
	A. bit	2	4	A. bit $\leftarrow 0$			
	PSW. bit	3	6	PSW. bit $\leftarrow 0$	×	×	×
	[HL]. bit	2	10	(HL) . bit $\leftarrow 0$			
SET1	CY	1	2	CY ← 1			1
CLR1	CY	1	2	$CY \leftarrow 0$			0
NOT1	CY	1	2	$CY \leftarrow \overline{CY}$			×
CALL	!addr16	3	6	$(SP - 1) \leftarrow (PC + 3)_{H}, (SP - 2) \leftarrow (PC + 3)_{L},$ $PC \leftarrow addr16, SP \leftarrow SP - 2$			
CALLT	[addr5]	1	8	$(SP - 1) \leftarrow (PC + 1)_{H}, (SP - 2) \leftarrow (PC + 1)_{L},$ $PC_{H} \leftarrow (00000000, addr5 + 1),$ $PC_{L} \leftarrow (00000000, addr5),$ $SP \leftarrow SP - 2$			
RET		1	6	$PC_{H} \leftarrow (SP + 1), PC_{L} \leftarrow (SP),$ $SP \leftarrow SP + 2$			
RETI		1	8	$\begin{array}{l} PC_{H} \leftarrow (SP+1), PC_{L} \leftarrow (SP), \\ PSW \leftarrow (SP+2), SP \leftarrow SP+3, \\ NMIS \leftarrow 0 \end{array}$	R	R	R
PUSH	PSW	1	2	$(SP - 1) \leftarrow PSW, SP \leftarrow SP - 1$			
	rp	1	4	$(SP - 1) \leftarrow rp_H, (SP - 2) \leftarrow rp_L,$ $SP \leftarrow SP - 2$			
POP	PSW	1	4	$PSW \leftarrow (SP), SP \leftarrow SP + 1$	R	R	R
	rp	1	6	$rp_{H} \leftarrow (SP + 1), rp_{L} \leftarrow (SP),$ $SP \leftarrow SP + 2$			
MOVW	SP, AX	2	8	$SP \leftarrow AX$			
	AX, SP	2	6	$AX \leftarrow SP$			
BR	!addr16	3	6	PC ← addr16			
	\$addr16	2	6	$PC \leftarrow PC + 2 + jdisp8$			
	AX	1	6	$PC_{H} \leftarrow A, PC_{L} \leftarrow X$			

Remark One instruction clock cycle is one cycle of the CPU clock (fcPu), selected by the processor clock control register (PCC).

Mnemonic	Operand	Byte	Clock	Operation	Flag
					Z AC CY
BC	\$addr16	2	6	$PC \leftarrow PC + 2 + jdisp8$ if $CY = 1$	
BNC	\$addr16	2	6	$PC \leftarrow PC + 2 + jdisp8$ if $CY = 0$	
BZ	\$addr16	2	6	$PC \leftarrow PC + 2 + jdisp8$ if $Z = 1$	
BNZ	\$addr16	2	6	$PC \leftarrow PC + 2 + jdisp8$ if $Z = 0$	
BT	saddr. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if (saddr. bit) = 1	
	sfr. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if sfr. bit = 1	
	A. bit , \$addr16	3	8	$PC \leftarrow PC + 3 + jdisp8$ if A. bit = 1	
	PSW. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if PSW. bit = 1	
BF	saddr. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if (saddr. bit) = 0	
	sfr. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if sfr. bit = 0	
	A. bit, \$addr16	3	8	$PC \leftarrow PC + 3 + jdisp8$ if A. bit = 0	
	PSW. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if PSW. bit = 0	
DBNZ	B, \$addr16	2	6	B ← B – 1, then PC ← PC + 2 + jdisp8 if B ≠ 0	
	C, \$addr16	2	6	$C \leftarrow C - 1$, then PC \leftarrow PC + 2 + jdisp8 if C $\neq 0$	
	saddr, \$addr16	3	8	$(saddr) \leftarrow (saddr) - 1$, then PC \leftarrow PC + 3 + jdisp8 if(saddr) $\neq 0$	
NOP		1	2	No Operation	
EI		3	6	IE ← 1(Enable Interrupt)	
DI		3	6	$IE \leftarrow 0(Disable Interrupt)$	
HALT		1	2	Set HALT Mode	
STOP		1	2	Set STOP Mode	

Remark One instruction clock cycle is one cycle of the CPU clock (fcPU), selected by the processor clock control register (PCC).

8. ELECTRICAL SPECIFICATIONS

Absolute Maximum Ratings (T_A = 25°C)

Parameter	Symbol	Conditions		Ratings	Unit		
Supply voltage	Vdd, AVdd	V _{DD} = AV _{DD}		-0.3 to +6.5	V		
	VPP			-0.3 to +10.5	V		
Input voltage	VII	Pins other than P	50 to P53	-0.3 to V _{DD} + 0.3	V		
	Vı2	P50 to P53	With N-ch open drain	-0.3 to +13	V		
Output voltage	Vo			-0.3 to V _{DD} + 0.3	V		
Output current, high	Іон	Per pin	μPD78F9116B	-10	mA		
		Total for all pins		Total for all pins -30		-30	mA
		Per pin	μPD78F9116B(A)	10	mA		
		Total for all pins	Total for all pins 120		mA		
Output current, low	lol	Per pin	μPD78F9116B	30	mA		
		Total for all pins		160	mA		
		Per pin	μPD78F9116B(A)	-7	mA		
		Total for all pins	Total for all pins		mA		
Operating ambient temperature	TA	In normal operation mode		-40 to +85	°C		
		During flash memory programming		10 to 40	°C		
Storage temperature	Tstg			-40 to +125	°C		

- Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.
- **Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of port pins.

Resonator	Recommended Circuit	Parameter	Conditions	MIN.	TYP.	MAX.	Unit
Ceramic		Oscillation frequency (fx) ^{Note 1}	V _{DD} = 4.5 to 5.5 V	1.0		10.0	MHz
resonator	VPP X1 X2		V _{DD} = 3.0 to 5.5 V	1.0		6.0	MHz
	┊│ ┝┤᠋᠐┝─┥		V _{DD} = 1.8 to 5.5 V	1.0		5.0	MHz
		Oscillation stabilization time ^{Note 2}	After V _{DD} reaches oscillation voltage range MIN.			4	ms
Crystal	VPP X1 X2	Oscillation frequency (fx)Note 1	V _{DD} = 4.5 to 5.5 V	1.0		10.0	MHz
resonator			V _{DD} = 3.0 to 5.5 V	1.0		6.0	MHz
			V _{DD} = 1.8 to 5.5 V	1.0		5.0	MHz
		Oscillation stabilization	V _{DD} = 4.5 to 5.5 V			10	ms
	///	time ^{Note 2}	V _{DD} = 1.8 to 5.5 V			30	
External	X1 X2	X1 input frequency (fx) ^{Note 1}	V _{DD} = 4.5 to 5.5 V	1.0		10.0	MHz
clock			VDD = 3.0 to 5.5 V	1.0		6.0	MHz
			VDD = 1.8 to 5.5 V	1.0		5.0	MHz
	Å	X1 input high-/low-level	V _{DD} = 4.5 to 5.5 V	45		500	ns
		width (txн, tx∟)	V _{DD} = 3.0 to 5.5 V	75		500	ns
			VDD = 1.8 to 5.5 V	85		500	ns
	X1 X2	X1 input frequency (fx) ^{Note 1}	V _{DD} = 2.7 to 5.5 V	1.0		5.0	MHz
		X1 input high-/low-level width (txн, tx⊥)		85		500	ns

	T 40.1 0500	
System Clock Oscillator Characteristics	$I_A = -40 \text{ to } +85^{\circ}\text{C}$, V D D = 1.8 to 5.5 V)

- Notes 1. Indicates only oscillator characteristics. Refer to AC characteristics for instruction execution time.
 - **2.** Time required to stabilize oscillation after a reset or STOP mode release. Use the resonator that stabilizes oscillation during the oscillation wait time.
- Caution When using the system clock oscillator, wire as follows in the area enclosed by the broken lines in the above figures to avoid an adverse effect from wiring capacitance.
 - Keep the wiring length as short as possible.
 - Do not cross the wiring with the other signal lines.
 - Do not route the wiring near a signal line through which a high fluctuating current flows.
 - Always make the ground point of the oscillator capacitor the same potential as Vss.
 - Do not ground the capacitor to a ground pattern through which a high current flows.
 - Do not fetch signals from the oscillator.
- **Remark** For the resonator selection and oscillator constant, customers are requested to either evaluate the oscillation themselves or apply to the resonator manufacturer for evaluation.

DC Characteristics (T_A = -40 to $+85^{\circ}$ C, V_{DD} = 1.8 to 5.5 V) (1/2)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit		
Output current, high	Іон	Per pin μPD78F91 Total for all pins Γοταί for all pins		116B			-1	mA	
								-15	mA
		Per pin	Per pin		9116B(A)			-1	mA
		Total for all pins					-11	mA	
Output current, low	loL	Per pin μPD78F9 Total for all pins μPD78F9 Per pin μPD78F9		116B			10	mA	
								80	mA
				9116B(A)			3	mA	
		Total for all	pins	IS				60	mA
Input voltage, high	VIH1	Pins other than descr below		scribed	V _{DD} = 2.7 to 5.5 V	0.7 Vdd		VDD	V
					V _{DD} = 1.8 to 5.5 V	0.9 VDD		VDD	V
	VIH2	P50 to P53 N-ch	N-ch o	open drain	V _{DD} = 2.7 to 5.5 V	0.7 Vdd		12	V
				V _{DD} = 1.8 to 5.5 V, TA = 25 to 85 °C	0.9 V _{DD}		12	V	
	Vінз	RESET, P20 to P25		5	V _{DD} = 2.7 to 5.5 V	0.8 VDD		Vdd	V
				V _{DD} = 1.8 to 5.5 V	0.9 Vdd		VDD	V	
	VIH4	X1, X2		V _{DD} = 4.5 to 5.5 V	V _{DD} -0.5		VDD	V	
					V _{DD} = 1.8 to 5.5 V	VDD-0.1		Vdd	V
Input voltage, low	VIL1 Pins other th below	han described		V _{DD} = 2.7 to 5.5 V	0		0.3 VDD	V	
		below		V _{DD} = 1.8 to 5.5 V	0		0.1 VDD	V	
	VIL2	P50 to P53 N-ch	h open drain	V _{DD} = 2.7 to 5.5 V	0		0.3 VDD	V	
					V _{DD} = 1.8 to 5.5 V, TA = 25 to 85 °C	0		0.1 Vdd	V
	Vil3	RESET, P20 to P25		5	V _{DD} = 2.7 to 5.5 V	0		0.2 V _{DD}	V
				V _{DD} = 1.8 to 5.5 V	0		0.1 VDD	V	
	VIL4	X1, X2			V _{DD} = 4.5 to 5.5 V	0		0.4	V
					V _{DD} = 1.8 to 5.5 V	0		0.1	V
Output voltage, high	V _{OH1}	V _{DD} = 4.5 to 5.5 V, Iон = -1 m			Ą	Vdd - 1.0			V
	Vон2	V _{DD} = 1.8 to 5.5 V, Іон = -100			μA	V _{DD} -0.5			V
	VoL1 Pins other than P50 to P53		$V_{DD} = 4.5 \text{ to } 5.5 \text{ V}, \text{ IoL} = 10 \text{ mA}$ (μ PD78F9116B)				1.0	V	
		ν _ι (μ		V _{DD} = 4.5 to 5.5 V, I _{OL} = 3 mA (µPD78F9116B(A))				1.0	V
			VD	$I_{DD} = 1.8 \text{ to } 5.5 \text{ V}, \text{ IoL} = 400 \ \mu\text{A}$				0.5	V
	Vol2	(μP Vde		DD = 4.5 to 5.5 V, Io∟ = 10 mA ℓPD78F9116B)				1.0	V
			o = 4.5 to 5. PD78F9116	5 V, Io∟ = 3 mA B(A))			1.0	V	
		VDD		= 1.8 to 5	5 V, lo∟ = 1.6 mA			0.4	V

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of port pins.

DC Characteristics (TA = -40 to +85°C, VDD = 1.8 to 5.5 V) (2/2)

Parameter	Symbol	I Conditions			TYP.	MAX.	Unit
Input leakage current, high	Ішні	Pins other than X1, X2, or P50 to P53	$V_{\text{IN}} = V_{\text{DD}}$			3	μA
	ILIH2	X1, X2				20	μA
	Іцнз	P50 to P53 (N-ch open VIN = 12 V drain)				20	μΑ
Input leakage current, low	ILIL1	Pins other than X1, X2, or VIN = 0 V P50 to P53 X1, X2				-3	μΑ
	ILIL2					-20	μA
	Ililis	P50 to P53 (N-ch open drain)				-3 ^{Note 1}	μΑ
Output leakage current, high	Ігон	Vout = VDD				3	μΑ
Output leakage current, low	Ilol	Vout = 0 V			-3	μΑ	
Software pull-up resistor	R1	$V_{IN} = 0 V$, for pins other than	P50 to P53	50	100	200	kΩ
Power supply current	DD1 ^{Note 2}	10.0 MHz crystal oscillation operating mode	$V_{\text{DD}} = 5.0 \text{ V} \pm 10\%^{\text{Note 4}}$		10.0	20.0	mA
		6.0 MHz crystal oscillation operating mode	$V_{\text{DD}} = 5.0 \text{ V} \pm 10\%^{\text{Note 4}}$		6.0	12.0	mA
		5.0 MHz crystal oscillation operating mode (C1 = C2 = 22 pF)	$V_{DD} = 5.0 \text{ V} \pm 10\%^{\text{Note 4}}$		4.0	10.0	mA
			$V_{\text{DD}} = 3.0 \text{ V} \pm 10\%^{\text{Note 5}}$		1.0	2.5	mA
			$V_{\text{DD}} = 2.0 \text{ V} \pm 10\%^{\text{Note 5}}$		0.8	2.0	mA
	IDD2 ^{Note 2}	10.0 MHz crystal oscillation HALT mode	$V_{\text{DD}} = 5.0 \text{ V} \pm 10\%^{\text{Note 4}}$		1.2	6.0	mA
		6.0 MHz crystal oscillation HALT mode	$V_{\text{DD}} = 5.0 \text{ V} \pm 10\%^{\text{Note 4}}$		0.9	2.8	mA
		5.0 MHz crystal oscillation HALT mode (C1 = C2 = 22 pF)	$V_{DD} = 5.0 \text{ V} \pm 10\%^{\text{Note 4}}$		0.6	2.5	mA
			$V_{\text{DD}} = 3.0 \text{ V} \pm 10\%^{\text{Note 5}}$		0.3	2.0	mA
			$V_{\text{DD}} = 2.0 \text{ V} \pm 10\%^{\text{Note 5}}$		0.2	1.5	mA
	DD3 ^{Note 2}	STOP mode	$V_{DD} = 5.0 \text{ V} \pm 10\%$		0.1	30	μA
			$V_{DD} = 3.0 \ V \pm 10\%$		0.05	10	μA
			$V_{DD} = 2.0 \text{ V} \pm 10\%$		0.05	10	μA
	IDD4 ^{Note 3}	10.0 MHz crystal oscillation A/D operating mode	$V_{\text{DD}} = 5.0 \text{ V} \pm 10\%^{\text{Note 4}}$		11.0	22.5	mA
		6.0 MHz crystal oscillation A/D operating mode	$V_{\text{DD}} = 5.0 \text{ V} \pm 10\%^{\text{Note 4}}$		7.0	14.5	mA
		5.0 MHz crystal oscillation A/D operating mode (C1 = C2 = 22 pF)	$V_{\text{DD}} = 5.0 \ \text{V}{\pm}10\%^{\text{Note 4}}$		5.0	12.5	mA
			$V_{\text{DD}} = 3.0 \ \text{V}{\pm}10\%^{\text{Note 5}}$		2.0	5.0	mA
			$V_{DD} = 2.0 \text{ V} \pm 10\%^{\text{Note 5}}$		1.8	4.5	mA

Notes 1. When port 5 is in input mode, a low-level input leakage current of $-60 \ \mu\text{A}$ (MAX.) flows only for 1 cycle time after a read instruction has been executed to port 5.

- 2. The current flowing to the ports (including the current flowing through an on-chip pull-up resistor) and AV_{DD} current are not included.
- **3.** The current flowing to the ports (including the current flowing through an on-chip pull-up resistor) is not included.
- 4. High-speed mode operation (when processor clock control register (PCC) is set to 00H.)
- 5. Low-speed mode operation (when PCC is set to 02H).
- **Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of port pins.

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Operating frequency	fx	$V_{DD} = 4.5 \text{ to } 5.5 \text{ V}$	1.0		10.0	MHz
		V _{DD} = 3.0 to 5.5 V	1.0		6.0	MHz
		V _{DD} = 2.7 to 5.5 V	1.0		5.0	MHz
		V _{DD} = 1.8 to 5.5 V	1.0		1.25	MHz
Write current (V _{DD} pin) ^{№te}	Iddw	When V _{PP} supply voltage = V _{PP1} (5.0 MHz crystal oscillation operating mode)			21	mA
Write current (V₽₽ pin) ^{№te}	IPPW	When VPP supply voltage = VPP1			22.5	mA
Erase current (V _{DD} pin) ^{№te}	Idde	When V _{PP} supply voltage = V _{PP1} (5.0 MHz crystal oscillation operating mode)			3	mA
Erase current (V₽₽ pin) ^{№te}	IPPE	When VPP supply voltage = VPP1			115	mA
Unit erase time	ter		0.2	0.2	0.2	S
Total erase time	tera				20	S
Write count		Erase/write are regarded as 1 cycle			20	Times
VPP supply voltage	V _{PP0}	In normal operation	0		0.2V _{DD}	V
	V _{PP1}	During flash memory programming	9.7	10.0	10.3	V

Flash Memory Write/Erase Characteristics (T_A = 10 to 40°C, V_{DD} = 1.8 to 5.5 V)

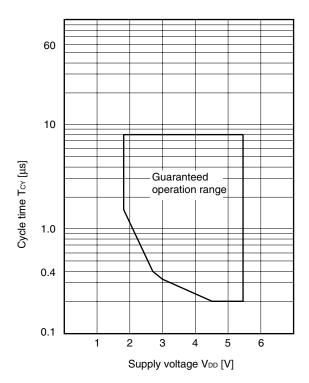
Note The current flowing to the ports (including the current flowing through an on-chip pull-up resistor) and AV_{DD} current are not included.

AC Characteristics

(1) Basic operation ($T_A = -40$ to $+85^{\circ}C$, $V_{DD} = 1.8$ to 5.5 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Cycle time	Тсү	V _{DD} = 4.5 to 5.5 V	0.2		8	μs
(minimum instruction execution time)		V _{DD} = 3.0 to 5.5 V	0.33		8	μs
		V _{DD} = 2.7 to 5.5 V	0.4		8	μs
		V _{DD} = 1.8 to 5.5 V	1.6		8	μs
TI80 input high-/low- level width	tт⊪, tт⊫	V _{DD} = 2.7 to 5.5 V	0.1			μs
		V _{DD} = 1.8 to 5.5 V	1.8			μs
TI80 input frequency	f⊤ı	V _{DD} = 2.7 to 5.5 V	0		4	MHz
		V _{DD} = 1.8 to 5.5 V	0		275	kHz
Interrupt input high- /low-level width	tinth, tintl	INTP0 to INTP2	10			μs
RESET low-level width	trs∟		10			μs
CPT20 input high- /low-level width	tсрн, tcpl		10			μs

Tcy vs Vdd



(2) Serial interface ($T_A = -40$ to $+85^{\circ}C$, $V_{DD} = 1.8$ to 5.5 V)

Parameter	Symbol	Con	ditions	MIN.	TYP.	MAX.	Unit
SCK20 cycle time	tKCY1	V _{DD} = 2.7 to 5.5 V		800			ns
		V _{DD} = 1.8 to 5.5 V		3200			ns
SCK20 high-/low-	tкнı,	V _{DD} = 2.7 to 5.5 V		tксү1/2 – 50			ns
level width	tĸ∟1	V _{DD} = 1.8 to 5.5 V		tkcy1/2 - 150			ns
SI20 setup time	tsik1	$V_{DD} = 2.7 \text{ to } 5.5 \text{ V}$		150			ns
(to SCK20↑)		V _{DD} = 1.8 to 5.5 V		500			ns
SI20 hold time	tksi1	V _{DD} = 2.7 to 5.5 V		400			ns
(from SCK20↑)				600			ns
SO20 output delay time from $SCK20\downarrow$	tkso1	$\label{eq:R} \begin{split} R &= 1 \ k \ \Omega, \\ C &= 100 \ p F^{\text{Note}} \end{split}$	V _{DD} = 2.7 to 5.5 V	0		250	ns
			V _{DD} = 1.8 to 5.5 V	0		1000	ns

(i) 3-wire serial I/O mode (SCK20...Internal clock output)

Note R and C are the load resistance and load capacitance of the SO output line.

Parameter	Symbol	Con	ditions	MIN.	TYP.	MAX.	Unit
SCK20 cycle time	t ксү2	V _{DD} = 2.7 to 5.5 V		800			ns
		V _{DD} = 1.8 to 5.5 V		3200			ns
SCK20 high-/low-	tкн2,	V _{DD} = 2.7 to 5.5 V		400			ns
level width	tkl2	V _{DD} = 1.8 to 5.5 V		1600			ns
SI20 setup time	tsik2	V _{DD} = 2.7 to 5.5 V		100			ns
(to SCK20↑)		V _{DD} = 1.8 to 5.5 V		150			ns
SI20 hold time	tksi2	V _{DD} = 2.7 to 5.5 V		400			ns
(from SCK20↑)		V _{DD} = 1.8 to 5.5 V		600			ns
SO20 output delay	tĸso2	$R = 1 k\Omega,$ $C = 100 \text{ pF}^{\text{Note}}$	V _{DD} = 2.7 to 5.5 V	0		300	ns
time from SCK20 \downarrow			V _{DD} = 1.8 to 5.5 V	0		1000	ns
SO20 setup time	tkas2	V _{DD} = 2.7 to 5.5 V	•			120	ns
(for SS20 \downarrow when SS20 is used)		V _{DD} = 1.8 to 5.5 V				400	ns
SO20 disable time	tkds2	V _{DD} = 2.7 to 5.5 V				240	ns
(for SS20↑ when SS20 is used)		V _{DD} = 1.8 to 5.5 V				800	ns

(ii) 3-wire serial I/O mode (SCK20...External clock input)

Note R and C are the load resistance and load capacitance of the SO output line.

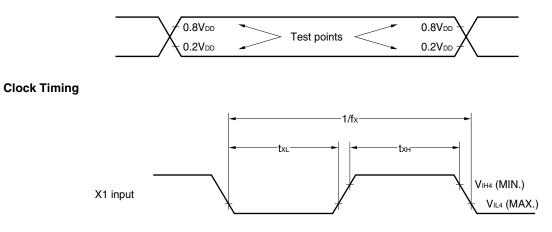
(iii) UART mode (Dedicated baud rate generator output)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Transfer rate		V _{DD} = 2.7 to 5.5 V			78125	bps
		V _{DD} = 1.8 to 5.5 V			19531	bps

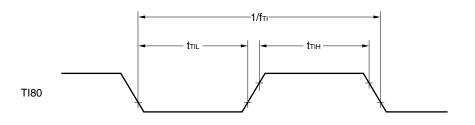
(iv) UART mode (external clock input)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
ASCK20 cycle time	tксүз	V _{DD} = 2.7 to 5.5 V	800			ns
		V _{DD} = 1.8 to 5.5 V	3200			ns
ASCK20 high-/low-	tкнз, tк∟з	V _{DD} = 2.7 to 5.5 V	400			ns
level width		V _{DD} = 1.8 to 5.5 V	1600			ns
Transfer rate		V _{DD} = 2.7 to 5.5 V			39063	bps
		V _{DD} = 1.8 to 5.5 V			9766	bps
ASCK20 rise/fall time	tr,				1	μs
	t⊧					

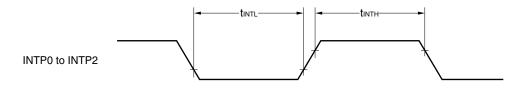
AC Timing Test Points (excluding X1 input)



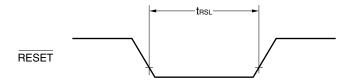
TI Timing



Interrupt Input Timing

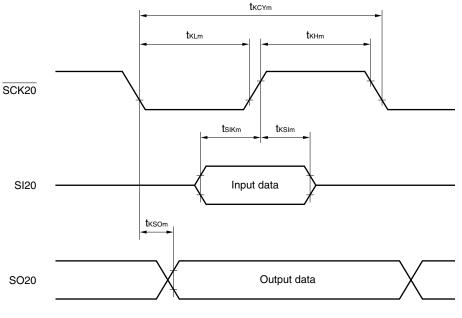


RESET Input Timing



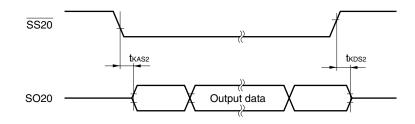
Serial Transfer Timing

3-wire serial I/O mode:

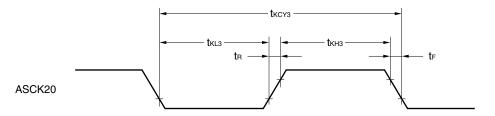


m = 1, 2

3-wire serial I/O mode (when $\overline{SS20}$ is used):



UART mode (external clock input):



Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Resolution			10	10	10	bit
Overall error ^{Note1,2}		$4.5~V \leq V_{\text{DD}} \leq 5.5~V$		±0.2	±0.4	%FSR
		$2.7~V \leq V_{\text{DD}} < 4.5~V$		±0.4	±0.6	%FSR
		$1.8 \text{ V} \leq V_{\text{DD}} < 2.7 \text{ V}$		±0.8	±1.2	%FSR
Conversion time	tCONV	$4.5~V \leq V_{\text{DD}} \leq 5.5~V$	12		100	μs
		$2.7~V \leq V_{\text{DD}} < 4.5~V$	14		100	μs
		$1.8 \text{ V} \leq V_{\text{DD}} < 2.7 \text{ V}$	28		100	μs
Zero-scale error ^{Note1,2}		$4.5~V \leq V_{\text{DD}} \leq 5.5~V$			±0.4	%FSR
		$2.7~V \leq V_{\text{DD}} < 4.5~V$			±0.6	%FSR
		$1.8 \text{ V} \leq \text{V}_{\text{DD}} < 2.7 \text{ V}$			±1.2	%FSR
Full-scale error ^{Note1,2}		$4.5~V \leq V_{\text{DD}} \leq 5.5~V$			±0.4	%FSR
		$2.7~V \leq V_{\text{DD}} < 4.5~V$			±0.6	%FSR
		$1.8~V \leq V_{\text{DD}} < 2.7~V$			±1.2	%FSR
Integral linearity	ILE	$4.5~V \leq V_{\text{DD}} \leq 5.5~V$			±2.5	LSB
error ^{Note1}		$2.7~V \leq V_{\text{DD}} < 4.5~V$			±4.5	LSB
		$1.8 \text{ V} \leq \text{V}_{\text{DD}} < 2.7 \text{ V}$			±8.5	LSB
Differential linearity	DLE	$4.5~V \leq V_{\text{DD}} \leq 5.5~V$			±1.5	LSB
error ^{Note1}		$2.7~V \leq V_{\text{DD}} < 4.5~V$			±2.0	LSB
		$1.8~V \leq V_{\text{DD}} < 2.7~V$			±3.5	LSB
Analog input voltage	VIAN		0		AVDD	V

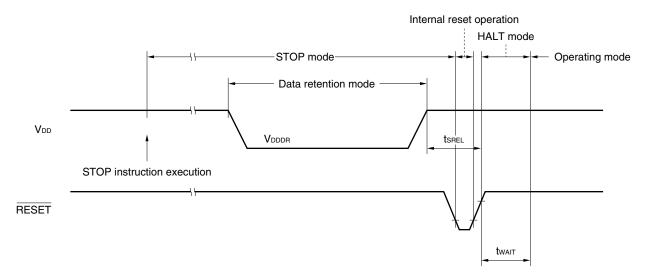
Notes 1. Excludes quantization error (±0.05%FSR).

2. It is indicated as a ratio to the full-scale value (%FSR).

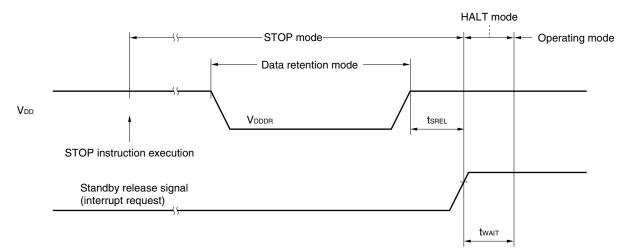
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Data retention supply voltage	VDDDR		1.8		5.5	V
Release signal set time	tsrel		0			μs
Oscillation	twait	Release by RESET		2 ¹⁵ /fx		ms
stabilization wait time ^{Note 1}		Release by interrupt request		Note 2		ms

- **Notes 1.** The oscillation stabilization wait time is the period during which the CPU operation is stopped to avoid unstable operation at the beginning of oscillation.
 - **2.** Selection of $2^{12}/fx$, $2^{15}/fx$, or $2^{17}/fx$ is possible with bits 0 to 2 (OSTS0 to OSTS2) of the oscillation stabilization time select register.
- Remark fx: System clock oscillation frequency

Data Retention Timing (STOP mode release by RESET)

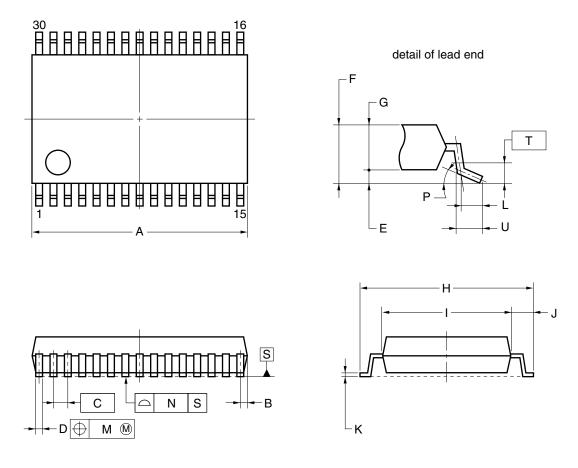


Data Retention Timing (Standby release signal: STOP mode release by interrupt signal)



9. PACKAGE DRAWING

30-PIN PLASTIC SSOP (7.62 mm (300))



NOTE

Each lead centerline is located within 0.13 mm of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS
A	9.85±0.15
В	0.45 MAX.
С	0.65 (T.P.)
D	$0.24^{+0.08}_{-0.07}$
Е	0.1±0.05
F	1.3±0.1
G	1.2
Н	8.1±0.2
I	6.1±0.2
J	1.0±0.2
К	0.17±0.03
L	0.5
М	0.13
Ν	0.10
Р	3°+5° -3°
Т	0.25
U	0.6±0.15
	S30MC-65-5A4-2

10. RECOMMENDED SOLDERING CONDITIONS

The μ PD78F9116B and 78F9116B(A) should be soldered and mounted under the following recommended conditions.

For the details of the recommended soldering conditions, refer to the document **Semiconductor Device Mounting Technology Manual (C10535E)**. For soldering methods and conditions other than those recommended below, contact your NEC sales representative.

Table 10-1. Surface Mounting Type Soldering Conditions

μPD78F9116BMC-5A4: 30-pin plastic SSOP (7.62 mm (300)) μPD78F9116BMC(A)-5A4: 30-pin plastic SSOP (7.62 mm (300))

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 235°C, Time: 30 seconds max. (at 210°C or higher), Count: Three times or less: 3 max., Exposure limit: 7days ^{№te} (after that, prebake at 125°C for 10 hours)	IR35-107-3
VPS	Package peak temperature: 215°C, Time: 40 seconds max. (at 200°C or higher), Count: Three time or less, Exposure limit: 7days ^{Note} (after that, prebake at 125°C for 10 hours)	VP15-107-3
Wave soldering	Solder bath temperature: 260°C max., Time: 10 seconds max., Count: Once Preheating temperature: 120°C or below (package surface temperature), Exposure limit : 7days ^{Note} (after that, prebake at 125°C for 10 hours)	WS60-107-1
Partial heating	Pin temperature: 300°C max., Time: 3 sec. max. (per pin row)	-

Note After opening the dry pack, store it at 25°C or less and 65% RH or less for the allowable storage period.

Caution Do not use different soldering methods together (except for partial heating).

APPENDIX A. DEVELOPMENT TOOLS

The following development tools are available for system development using the μ PD78F9116B and 78F9116B(A).

Software package

SP78K0S ^{Notes 1, 2}	CD-ROM in which the development tools (software) common to the 78K/0S Series are included as
	a package

Language Processing Software

RA78K0S ^{Notes 1, 2, 3}	Assembler package common to 78K/0S Series
CC78K0S ^{Notes 1, 2, 3}	C compiler package common to 78K/0S Series
DF789136 ^{Notes 1, 2, 3}	Device file for μ PD78F9116B

Flash Memory Writing Tools

Flashpro III (Model number: FL-PR3 ^{Note 4} , PG-FP3)	Dedicated flash programmer for on-chip flash memory
FA-30MC ^{Note 4}	Flash memory writing adapter

Debugging Tools (1/2)

IE-78K0S-NS In-circuit emulator serves to debug hardware and software when developing application synusing a 78K/0S Series product. It supports the ID78K0S-NS integrated debugger. Used in combination with an AC adapter, emulation probe, and interface adapter connecting to the machine.		
IE-78K0S-NS-AThe IE-78K0S-NS-A provides a coverage function in addition to the IE-78K0S-NS fIn-circuit emulatorenhancing the debug functions, including the tracer and timer functions.		
IE-70000-MC-PS-B AC adapter	Adapter used to supply power from a power outlet of 100 V AC to 240 V AC.	
IE-70000-98-IF-C Adapter when PC-9800 series PC (except notebook type) is used as the host machi supported).		
IE-70000-CD-IF-A PC card interface	PC card and interface cable when notebook PC is used as the host machine (PCMCIA socket supported).	
IE-70000-PC-IF-C Interface adapter	Adapter when using an IBM PC/AT [™] or compatible as the host machine.	
IE-70000-PCI-IF-A Adapter when using PC that includes a PCI bus as the IE-78K0S-NS host machine. Interface adapter		
IE-789136-NS-EM1 Emulation board	Board for emulation of the peripheral hardware peculiar to a device. Used in combination with an in-circuit emulator.	
NP-36GS ^{Note 4}	Board used to connect the in-circuit emulator to the target system. For a 30-pin plastic SSOP (MC-5A4 type), used in combination with NGS-30.	
NGS-30 ^{Note 4} Conversion socket	Conversion socket used to connect the NP-36GS to the target system board designed to mount a 30-pin plastic SSOP (MC-5A4 type).	

Notes 1. PC-9800 series (Japanese Windows™) based

- 2. IBM PC/AT or compatibles (Japanese/English Windows) based
- 3. HP9000 series 700[™] (HP-UX[™]) based, SPARCstation[™] (SunOS[™], Solaris[™]) based.
- 4. Products made by Naito Densei Machida Mfg. Co., Ltd. (Phone: +81-45-475-4191)

Remark RA78K0S, CC78K0S, SM78K0S, and ID78K0S-NS are used in combination with the DF789136.

Debugging Tools (2/2)

SM78K0S ^{Notes 1, 2}	System simulator common to 78K/0S Series
ID78K0S-NS ^{Notes 1, 2}	Integrated debugger common to 78K/0S Series
DF789136 ^{Notes 1, 2}	Device file for μ PD78F9116B

Notes 1. PC-9800 series (Japanese Windows) based

2. IBM PC/AT or compatibles (Japanese/English Windows) based

Remark RA78K0S, CC78K0S, SM78K0S, and ID78K0S-NS are used in combination with the DF789136.

APPENDIX B. RELATED DOCUMENTS

The related documents listed above are subject to change without notice. Be sure to use the latest version of each document for designing.

Documents Related to Devices

Document Name	Document No.
μΡD789101A, 102A, 104A, 111A, 112A, 114A, 101A(A), 102A(A), 104A(A), 111A(A), 112A(A), 114A(A) Data Sheet	U14590E
μPD78F9116B, 78F9116B(A) Data Sheet	This manual
μPD789104A, 789114A, 789124A, 789134A Subseries User's Manual	U14643E
78K/0S Series User's Manual Instructions	U11047E

Documents Related to Development Software Tools (User's Manuals)

Document Name		Document No.
RA78K0S Assembler Package	Operation	U14876E
	Language	U14877E
	Structured Assembly Language	U11623E
CC78K0S C Compiler	Operation	U14871E
	Language	U14872E
SM78K0S, SM78K0 System Simulator	Operation (Windows Based)	U14611E
Ver. 2.10 or Later		
SM78K Series System Simulator Ver. 2.10 or Later	External Part User Open Interface Specification	U15006E
ID78K0-NS, ID78K0S-NS Integrated Debugger Ver. 2.20 or Later	Operation (Windows Based)	U14910E
Project Manager Ver. 3.12 or Later (Windows Based)		U14610E

Documents Related to Development Hardware Tools (User's Manuals)

Document Name	Document No.
IE-78K0S-NS In-Circuit Emulator	U13549E
IE-78K0S-NS-A In-Circuit Emulator	U15207E
IE-789136-NS-EM1 Emulation Board	U14363E

Documents Related to Flash Memory Writing

Document Name	Document No.
PG-FP3 Flash Memory Programmer User's Manual U	

Caution The related documents listed above are subject to change without notice. Be sure to use the latest version of each document for designing.

Other Related Documents

Document Name	Document No.
SEMICONDUCTOR SELECTION GUIDE - Products & Packages -	X13769E
Semiconductor Device Mounting Technology Manual	C10535E
Quality Grades on NEC Semiconductor Devices	
NEC Semiconductor Device Reliability/Quality Control System	C10983E
Guide to Prevent Damage for Semiconductor Devices by Electrostatic Discharge (ESD)	C11892E

Caution The related documents listed above are subject to change without notice. Be sure to use the latest version of each document for designing.

[MEMO]

[MEMO]

[MEMO]

- NOTES FOR CMOS DEVICES -

① PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

② HANDLING OF UNUSED INPUT PINS FOR CMOS

Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

③ STATUS BEFORE INITIALIZATION OF MOS DEVICES

Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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- · Ordering information
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- · Availability of related technical literature
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- Network requirements

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